**CETECOM™****CETECOM ICT Services**
consulting - testing - certification >>>

TEST REPORT

Test report no.: 1-8094/14-02-06

Deutsche
Akkreditierungsstelle
D-PL-12076-01-00

Testing laboratory

CETECOM ICT Services GmbH

Untertuerkheimer Strasse 6 – 10

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Internet: <http://www.cetecom.com>e-mail: ict@cetecom.com**Accredited Testing Laboratory:**

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00

Applicant

Phonak AG

Laubisruetistrasse 28

8712 Staefa / SWITZERLAND

Phone: -/-

Fax: +41 5 89 28 20 11

Contact: Valentina Shcherba

e-mail: valentina.shcherba@phonak.com

Phone: +41 5 89 28 01 01

Manufacturer

Phonak AG

Laubisruetistrasse 28

8712 Staefa / SWITZERLAND

Test standard/s

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS-Gen Issue 3

General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Hearing Aid
Model name: Phonak Audéo V90-312
FCC ID: KWC-WHSRIC2
IC: 2262A-WHSRIC2
Frequency: 10.6 MHz
Technology tested: Modulated single carrier
Antenna: Integrated ferrite coil antenna (inductive)
Power supply: 1.30 V DC by Zink - Air battery
Temperature range: -20°C to +50°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:



Tobias Wittenmeier
Experienced
Radio Communications & EMC

Test performed:



Marco Bertolino
Specialist
Radio Communications & EMC

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CETECOM ICT Services GmbH.

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Under no circumstances does the CETECOM ICT Services GmbH test report include or imply any product or service warranties from CETECOM ICT Services GmbH, including, without limitation, any implied warranties of merchantability, fitness for purpose, or non-infringement, all of which are expressly disclaimed by CETECOM ICT Services GmbH.

All rights and remedies regarding vendor's products and services for which CETECOM ICT Services GmbH has prepared this test report shall be provided by the party offering such products or services and not by CETECOM ICT Services GmbH.

In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2014-06-05
Date of receipt of test item:	2014-08-08
Start of test:	2014-08-11
End of test:	2014-08-14
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	-/-	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS-Gen Issue 3	2010-12	General Requirements and Information for the Certification of Radio Apparatus

4 Test environment

Temperature:	T_{nom}	+22 °C during room temperature tests
	T_{max}	+50 °C during high temperature tests
	T_{min}	-20 °C during low temperature tests
Relative humidity content:		52 %
Barometric pressure:		not relevant for this kind of testing
Power supply:	V_{nom}	1.30 V DC by Zink - Air battery
	V_{max}	1.45 V
	V_{min}	1.10 V

5 Test item

Kind of test item	:	Hearing Aid
Type identification	:	Phonak Audéo V90-312 Equivalent variants: Phonak Audéo V70-312 Phonak Audéo V50-312 Phonak Audéo V30-312
S/N serial number	:	TX units: 1424H04P1V90312 1424H04NGV90312 RX units: 1424H04NHV90312
HW hardware status	:	Paris RIC-312_1
SW software status	:	RF test software / Firmware 1.0.5.0
Frequency band [MHz]	:	10.6
Type of radio transmission	:	Base band modulation
Use of frequency spectrum	:	
Type of modulation	:	8-DPSK (DQPSK)
Number of channels	:	1
Antenna	:	Integrated ferrite coil antenna (inductive)
Power supply	:	1.30 V DC by Zink - Air battery
Temperature range	:	-20°C to +50 °C

5.1 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-8094/14-02-01_AnnexA
1-8094/14-02-01_AnnexB
1-8094/14-02-01_AnnexD

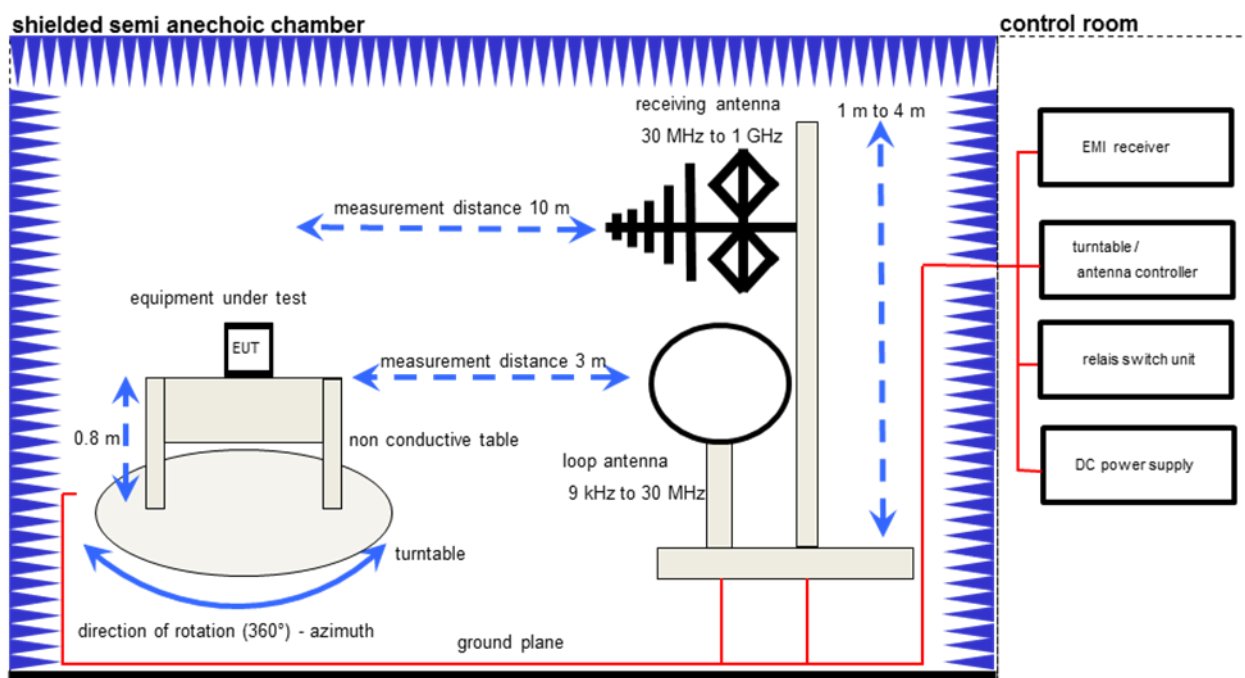
6 Test laboratories sub-contracted

None

7 Description of the test setup

7.1 Radiated measurements

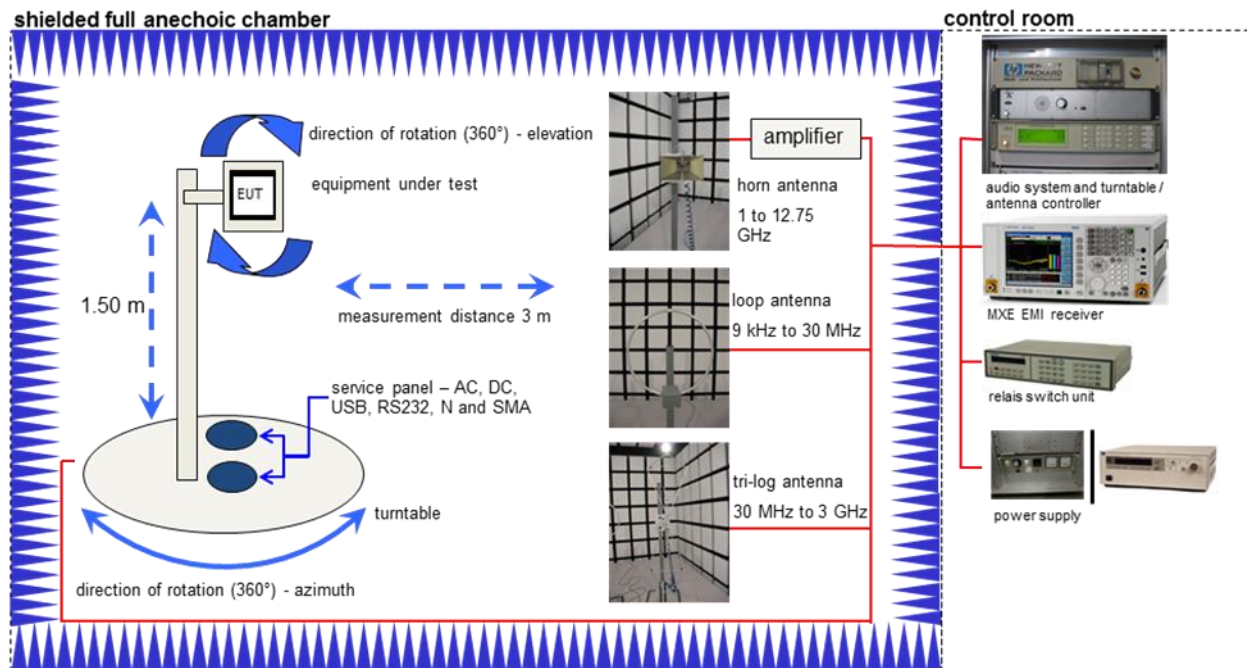
The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analysers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
Software	EMC32 V. 9.12.05	R&S	-/-	-/-
Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368
EMI Test Receiver	ESCI 3	R&S	100083	300003312
Turntable Interface-Box	Model 105637	ETS-LINDGREN	44583	300003747
TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787
Test Receiver	ESH2	R&S	871921/095	300002505
Loop Antenna 9 KHz - 30 MHz	HFH2-Z2	R&S	872096/61	300001824
EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059

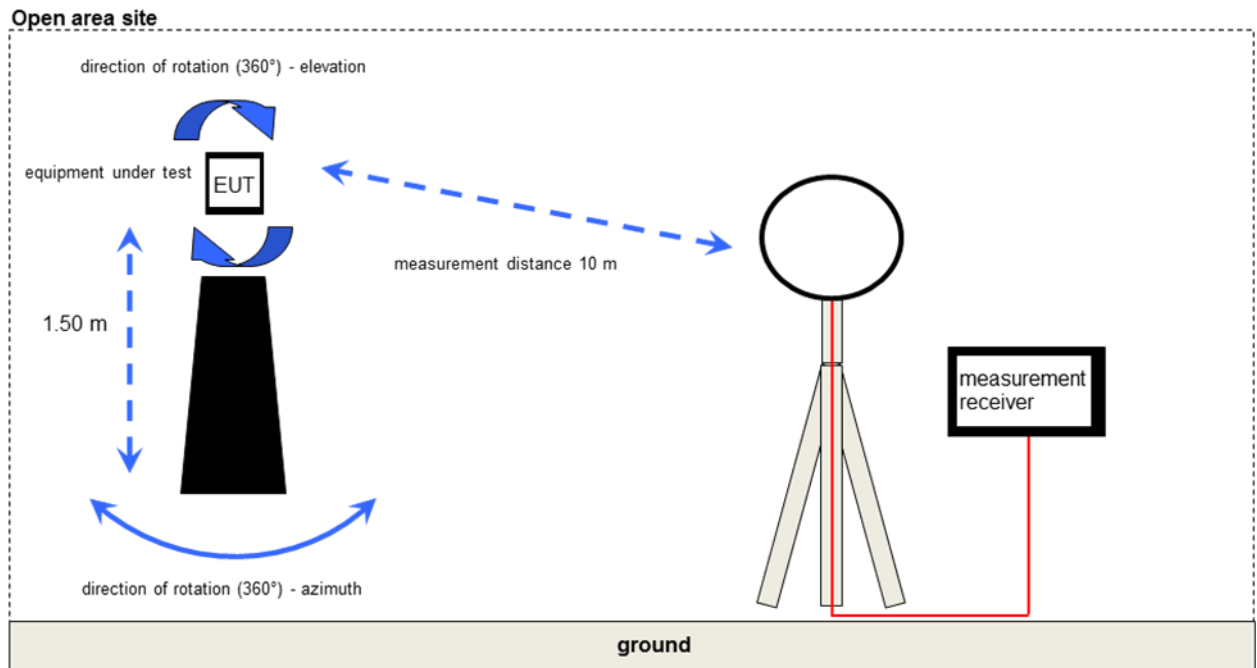
7.2 Radiated measurements chamber C



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405
TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854
Active Loop Antenna	6502	EMCO	8905-2342	300000256
Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996
Switch / Control Unit	3488A	HP Meßtechnik	*	300000199
Switch / Control Unit	3488A	HP Meßtechnik	2719A15013	300001156
Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997
Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143

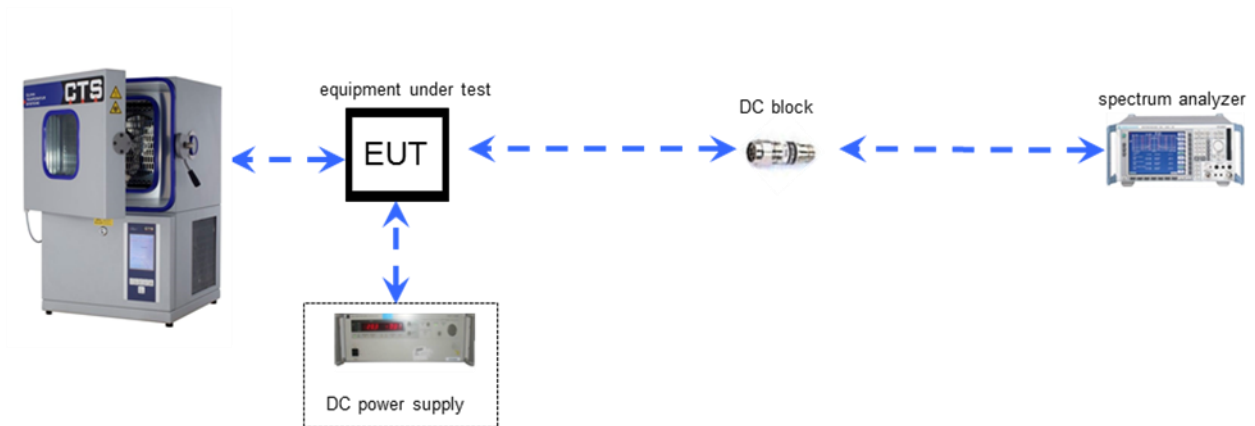
7.3 Open area site



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
Test Receiver	ESH2	R&S	871921/095	300002505
Loop Antenna 9 KHz - 30 MHz	HFH2-Z2	R&S	872096/61	300001824

7.4 Conducted measurements



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
DC Power Supply 0 – 32V	1108-32	Heiden	001802	300001383
Temperature Test Chamber	T-40/50	CTS GmbH	064023	300003540
Spectrum Analyzer 20 Hz - 50 GHz	FSU50	R&S	200012	300003443

8 Summary of measurement results



No deviations from the technical specifications were ascertained



There were deviations from the technical specifications ascertained

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS GEN Issue 3	Passed	2014-08-19	-/-

Test Specification Clause	Test Case	Temperature Conditions	Power Source Voltages	Pass	Fail	NA	NP	Results
RSS GEN	Bandwidth of the modulated carrier	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.209	Fieldstrength of fundamental	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.209	Fieldstrength of harmonics and spurious	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.109	Receiver spurious emissions	Nominal	Nominal	☒	☐	☐	☐	complies

Note: NA = Not Applicable; NP = Not Performed

9 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

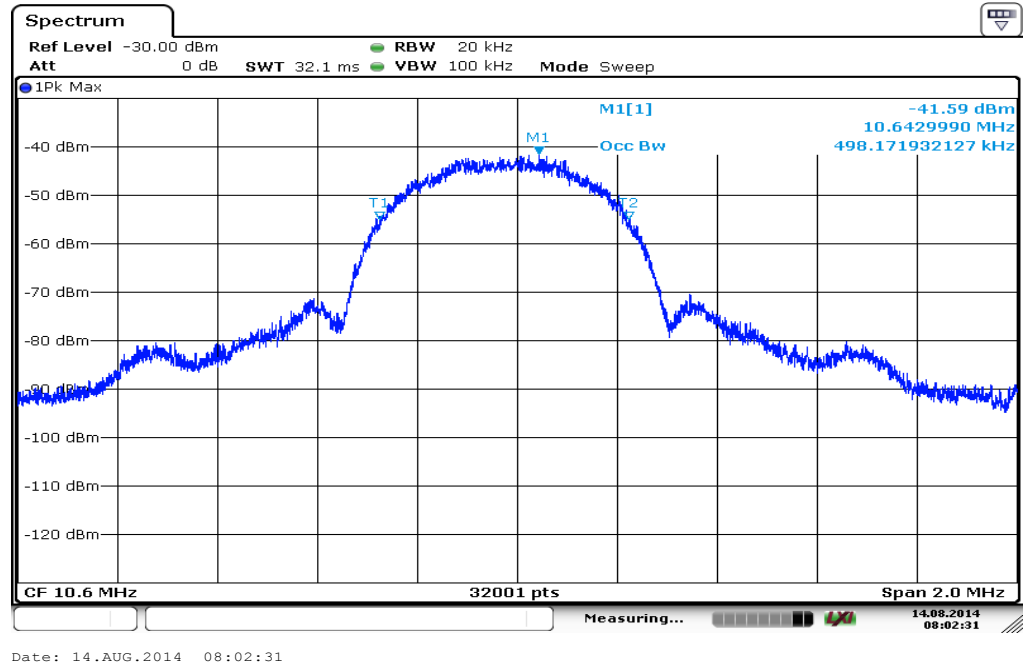
10 Measurement results**10.1 Bandwidth of the modulated carrier****Measurement:****Limits:**

Measurement parameter	
Detector:	Peak
Resolution bandwidth:	20 kHz
Video bandwidth:	> RBW
Trace-Mode:	Max Hold

FCC	IC
Bandwidth of the modulated carrier	

Result:

	Occupied Bandwidth (kHz)
99%	498.17

Plots:**Plot 1: OBW (99 % - bandwidth)**

10.2 Field strength of the fundamental

Measurement:

Measurement parameter	
Detector:	Quasi Peak (CISPR)
Resolution bandwidth:	10kHz
Trace-Mode:	Max Hold

Limits:

FCC		IC
Fundamental Frequency (MHz)	Field strength of Fundamental ($\mu\text{V/m}$)	Measurement distance (m)
1.705 – 30.0	30	30

Result:

TEST CONDITIONS		MAXIMUM POWER (dB $\mu\text{V/m}$)	
Frequency		10.6 MHz	10.6 MHz
Mode		at 1 m distance	at 30 m distance
T_{nom}	V_{nom}	45.5	-14.5
Measurement uncertainty		± 3 dB	

Recalculation to a measurement distance of 30m with a correction of 60 dB/decade.

Verdict: **Passed**

10.3 Field strength of the harmonics and spurious

Measurement:

Measurement parameter	
Detector:	Average / Quasi Peak
Sweep time:	Auto
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz > F > 30 MHz: 9 kHz F > 30 MHz: 120 kHz
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz > F > 30 MHz: 100 kHz F > 30 MHz: 300 kHz
Span:	See plot!
Trace-Mode:	Max hold

Limits:

FCC		IC
Field strength of the harmonics and spurious.		
Frequency (MHz)	Field strength (μV/m)	Measurement distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dBμV/m)	30
30 – 88	100 (40 dBμV/m)	3
88 – 216	150 (43.5 dBμV/m)	3
216 – 960	200 (46 dBμV/m)	3

Result:

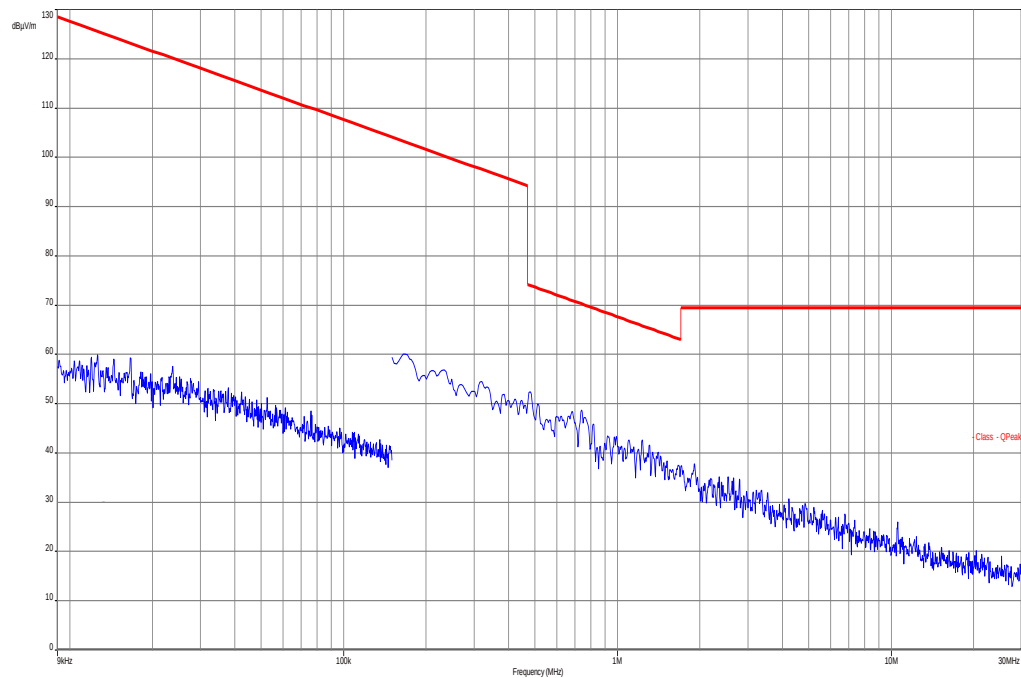
EMISSION LIMITATIONS				
f [MHz]	Detector	Limit max. allowed [dBμV/m]	Amplitude of emission [dBμV/m]	Results
Please take a look at the table below the 1 GHz plot.				

Verdict: **Passed**

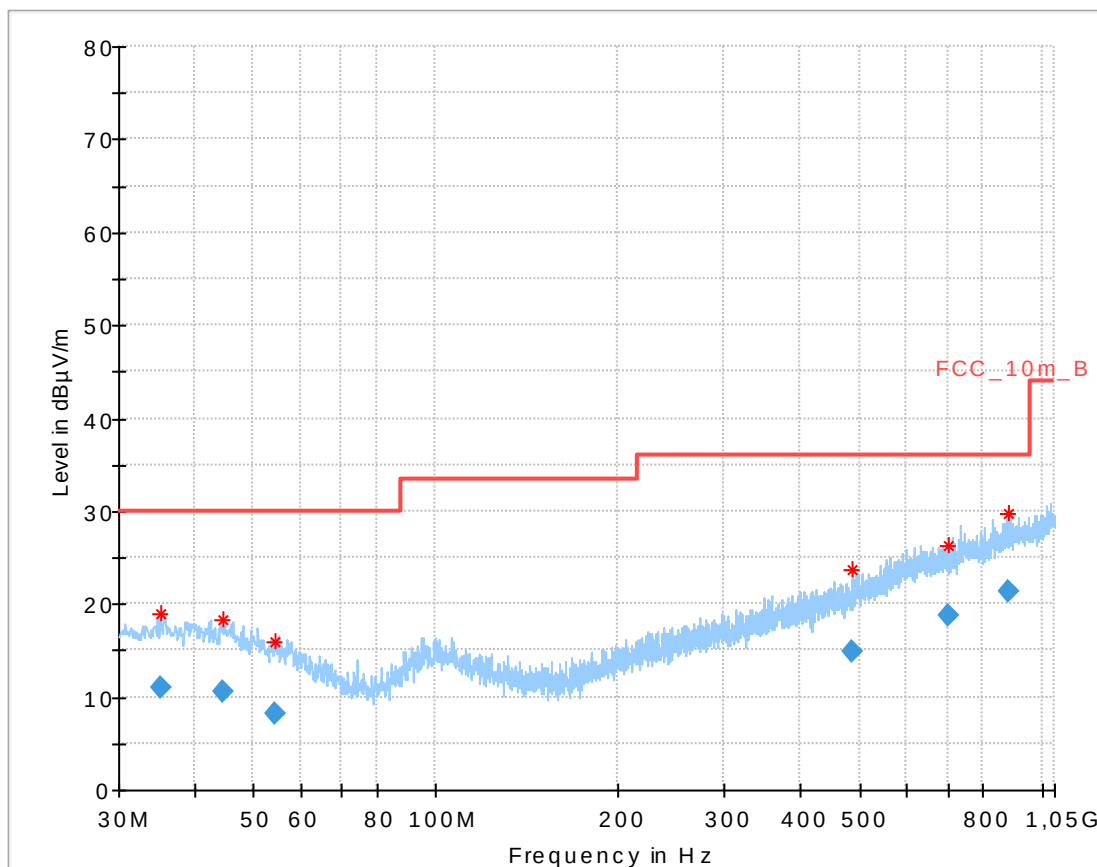
Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

Plots:

Plot 1: 9 kHz – 30 MHz



Plot 2: 30 MHz – 1000 MHz

**Final_Result:**

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
35.166000	10.97	30.00	19.03	1000.0	120.000	101.0	V	25	13.8
44.616300	10.49	30.00	19.51	1000.0	120.000	101.0	H	65	13.9
54.254700	8.18	30.00	21.82	1000.0	120.000	101.0	H	205	12.0
487.730100	14.95	36.00	21.05	1000.0	120.000	170.0	V	205	18.4
703.614150	18.84	36.00	17.16	1000.0	120.000	170.0	V	89	21.6
882.433200	21.28	36.00	14.72	1000.0	120.000	170.0	H	179	23.9

10.4 Receiver spurious emissions

Measurement:

Measurement parameter	
Detector:	Average / Quasi Peak
Sweep time:	Auto
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz > F > 30 MHz: 9 kHz F > 30 MHz: 120 kHz
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz > F > 30 MHz: 100 kHz F > 30 MHz: 300 kHz
Span:	See plot!
Trace-Mode:	Max hold

Limits:

FCC		IC
Field strength of the harmonics and spurious.		
Frequency (MHz)	Field strength ($\mu\text{V/m}$)	Measurement distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dB $\mu\text{V/m}$)	30
30 – 88	100 (40 dB $\mu\text{V/m}$)	3
88 – 216	150 (43.5 dB $\mu\text{V/m}$)	3
216 – 960	200 (46 dB $\mu\text{V/m}$)	3

Result:

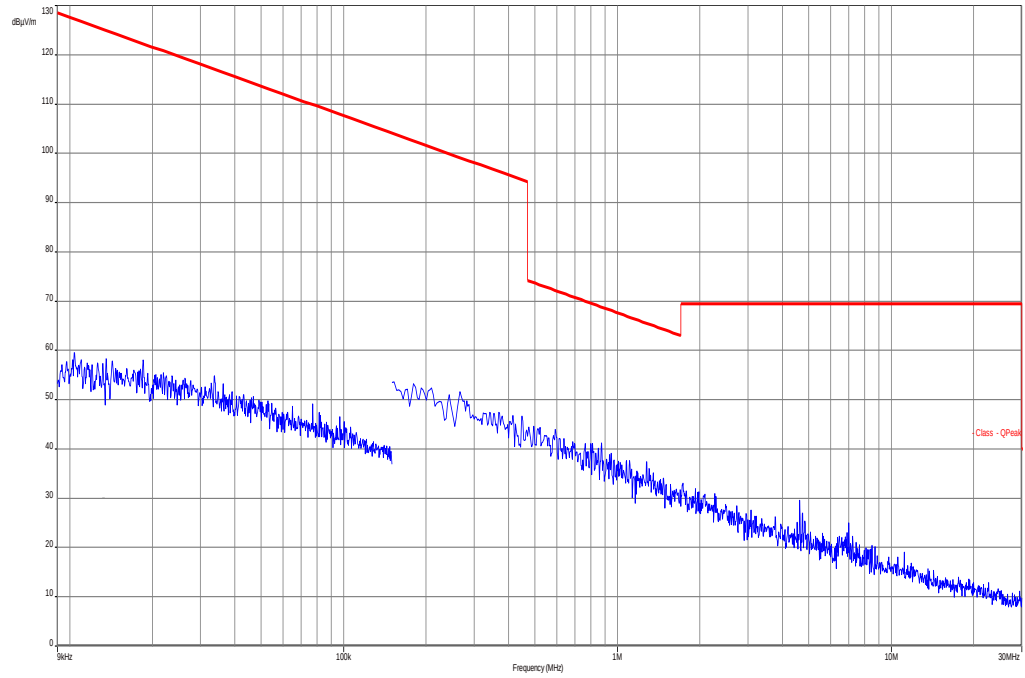
EMISSION LIMITATIONS				
f [MHz]	Detector	Limit max. allowed [dB $\mu\text{V/m}$]	Amplitude of emission [dB $\mu\text{V/m}$]	Results
Please take a look at the table below the 1 GHz plot.				

Verdict: Passed

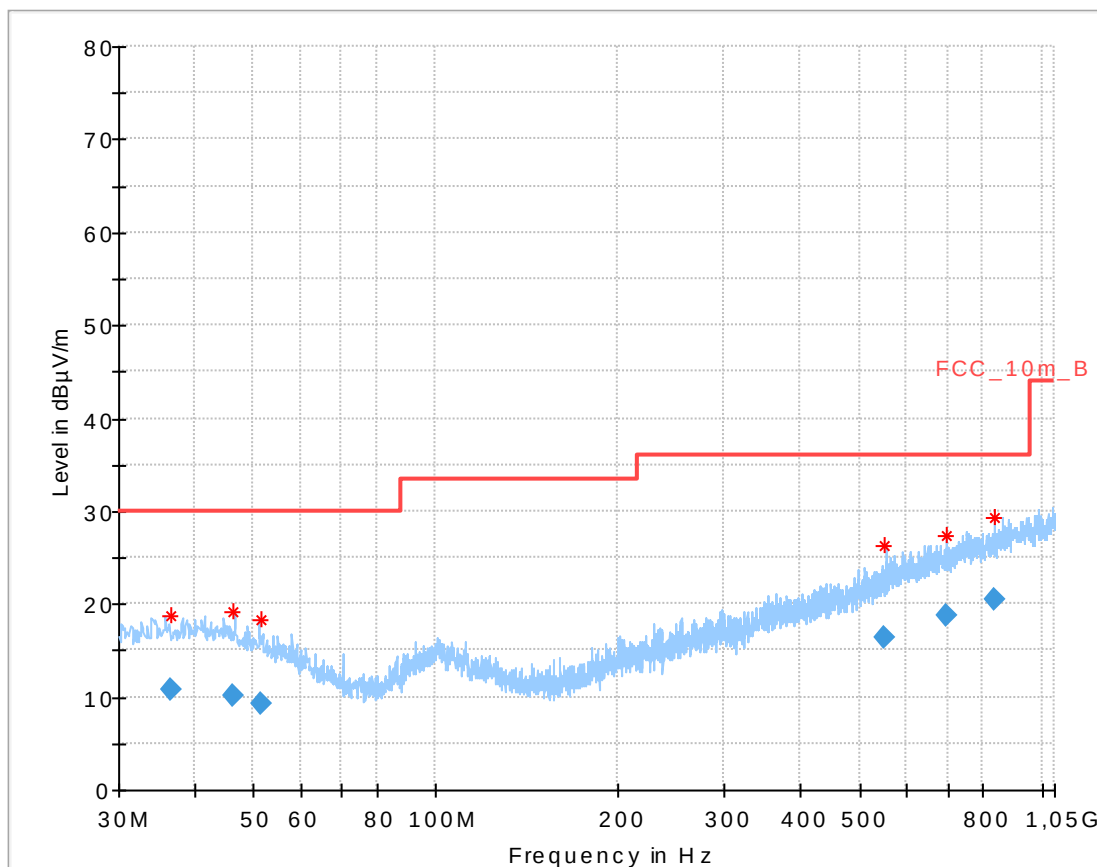
Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

Plots:

Plot 1: 9 kHz – 30 MHz



Plot 2: 30 MHz – 1000 MHz



Final_Result:

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
36.442500	10.83	30.00	19.17	1000.0	120.000	101.0	V	179	13.9
46.415700	10.24	30.00	19.76	1000.0	120.000	104.0	V	-25	13.5
51.443850	9.19	30.00	20.81	1000.0	120.000	101.0	H	155	12.4
551.673150	16.29	36.00	19.71	1000.0	120.000	170.0	H	155	19.3
696.311100	18.71	36.00	17.29	1000.0	120.000	166.0	H	65	21.5
832.958250	20.49	36.00	15.51	1000.0	120.000	170.0	H	179	23.2

11 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	45	Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368	g		
2	50	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP Meßtechnik	2920A04466	300000580	ne		
3	n. a.	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	27.01.2014	27.01.2015
4	n. a.	Funkstörmessempfänger 20Hz- 26,5GHz	ESU26	R&S	100037	300003555	k	28.02.2014	28.02.2015
5	n. a.	Antenna Tower	Model 2175	ETS-LINDGREN	64762	300003745	izw		
6	n. a.	Positioning Controller	Model 2090	ETS-LINDGREN	64672	300003746	izw		
7	n. a.	Turntable Interface-Box	Model 105637	ETS-LINDGREN	44583	300003747	izw		
8	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016
9	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
10	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	ne		
11	90	Active Loop Antenna 10 kHz to 30 MHz	6502	Kontron Psychotech	8905-2342	300000256	k	13.06.2013	13.06.2015
12	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	13.03.2014	13.03.2015
13	n. a.	Test Receiver	ESH2	R&S	871921/095	300002505	Ve	24.01.2014	24.01.2016
14	n. a.	Loop Antenna 9 KHz - 30 MHz	HFH2-Z2	R&S	872096/61	300001824	vKl!	09.03.2012	09.03.2015
15	n. a.	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/84193	300003889	Ve	26.09.2013	26.09.2015
16	n. a.	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	21.01.2014	21.01.2015
17	n. a.	Power Supply 0-20V, 0-5A	6632B	Agilent Technologies	GB42110541	400000562	vKl!	10.01.2013	10.01.2016

Agenda: Kind of Calibration

k calibration / calibrated
 ne not required (k, ev, izw, zw not required)
 ev periodic self verification
 Ve long-term stability recognized
 vKl! Attention: extended calibration interval
 NK! Attention: not calibrated

EK limited calibration
 zw cyclical maintenance (external cyclical maintenance)
 izw internal cyclical maintenance
 g blocked for accredited testing
 *) next calibration ordered / currently in progress

12 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2014-08-19

Annex B Further information**Glossary**

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software

Annex C Accreditation Certificate

Front side of certificate

Back side of certificate



Deutsche Akkreditierungsstelle GmbH

Befähigung gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
 Unterzeichnerin der Multilateralen Abkommen
 von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung



Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
 Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
 VoIP und DECT
 Akustik
 Funk einschließlich WLAN
 Short Range Devices (SRD)
 RFID
 WiMax und Richtfunk
 Mobilfunk (GSM / DC, Over the Air (OTA) Performance)
 Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
 Produktsicherheit
 SAR und Hearing Aid Compatibility (HAC)
 Umweltsimulation
 Smart Card Terminals
 Bluetooth
 Wi-Fi Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Beschluss vom 07.03.2014 mit der
 Akkreditierungsnummer D-PL-12076-01 und ist gültig 17.01.2018. Sie besteht aus diesem Deckblatt, der
 Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 77 Seiten.

Registrierungsnummer der Urkunde: D-PL-12076-01-00

Frankfurt am Main, 07.03.2014

Datei: 00000001-00000001

Dr. Andrea Dittmann
 Akkreditierungsleiter

Deutsche Akkreditierungsstelle GmbH

Standort Berlin
 Spittelmarkt 10
 10117 Berlin

Standort Frankfurt am Main
 Gartenstraße 6
 60594 Frankfurt am Main

Standort Braunschweig
 Bundesallee 100
 38115 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen
 Zustimmung der Deutschen Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate
 Weiterverbreitung des Deckblatts durch die umseitig genannte Kontaktperson der DAkkS in
 unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt,
 die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß dem Gesetz über die Akkreditierungsstelle (AkkStelleG) vom
 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments
 und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung
 im Zusammenhang mit der Vermarktung von Produkten (Abbl. L 218 vom 9. Juli 2008, S. 30).
 Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der
 Prüfungen in operation für Akkreditierung (EA), des Internationalen Accreditation Forum (IAF) und
 der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen
 erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
 EA: www.european-accreditation.org
 IAF: www.iaf.org
 ILAC: www.ilac.org

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

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